



Improved Memory Module for COTS NAND FLASH devices

ADCSS2012

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Project Overview

□ **Context**

- “Digital Latch Up and functional protection for COTS memories in space “ ITT of European Space Agency’s Directorate of Technical and Quality Management (ref. TEC-EDD-20009,42-T201-002ED, 25/11/2009)
- ESA Contract N. 4000102926/11/NL/AF based project

□ **Aim**

- Development of an Improved Memory Module IP Core to mitigate the radiation effects caused by heavy ions, neutrons and protons impact on a COTS based mass memory modules, making use of digital techniques

□ **Outputs**

- Configurable Improved Memory Module IP Core (IMMIPC)
- IMM Breadboard (IMMB) to test and verify the core functionality

Improved Memory Module Interface

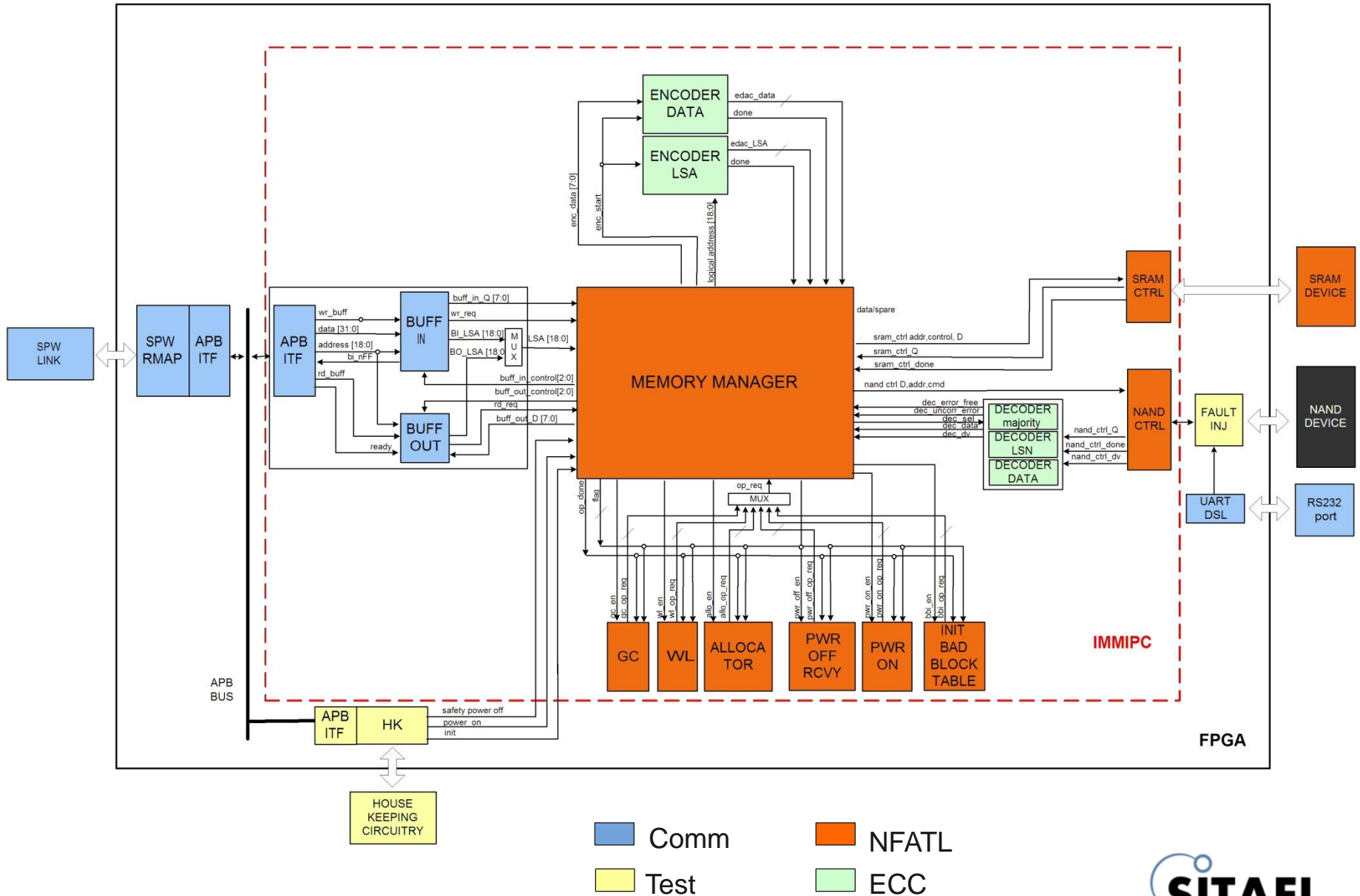
- ❑ **IMM is a black-box module embodying a reliable low-power mass-memory module**

- ❑ **Write-Read operations are controlled with a DMA like interface accessed via SpW-RMAP**
 - Fixed data size 2 (4) Kbyte Page access
 - Write operation:
 - Wait for IMM not busy
 - Write Page at logical address
 - Read Operation:
 - Request page read-DMA on R-Control register
 - Wait for end of DMA
 - Read Page Data from output buffer

What is in the Box

- ❑ **Nand Flash Address Translation Layer.**
- ❑ **Error Correction Code and control for Nand Flash errors and SEU/SEFI effect .**
- ❑ **Communication stack up to the Transport Layer: end-to-end reliable connection with (support to) flow control**
- ❑ **Test Utilities:**
 - Fault Injector on the Nand Flash Interface
 - HK circuit for current/temperature monitoring

IMM Block Diagram



Nand Flash Address Translation (1)

❑ **NAND FLASH MEMORIES**

- Flash Memory array is composed of blocks, and each block is made up of pages (1 block == 128 page == 512 Kbyte + Spare)
- Minimum erasable unit is a block
- Erase operation is time consuming (700 us)
- Some blocks are bad at shipping time
- Each block can be written only a limited number of times (100,000)
- Program page is possible only on erased paged, i.e. write–once
- Within a block, pages must be programmed in sequential order
- Each page is provided with additional storage called spare area to store metadata (ECC and additional information)



❑ **NAND FLASH ADDRESS TRANSLATION LAYER**

Nand Flash Address Translation (2)

❑ **NAND FLASH ADDRESS TRANSLATION LAYER Building Blocks:**

- Allocator
- Bad blocks Manager
- Wear leveler
- Garbage Collector
- Power off
- Power on

❑ **Resource Budget on ProASIC3E A3PE3000 FPGA :**

- Core cells : 10%
- Block rams: 15%

Nand Flash Address Translation (3)

❑ **ALLOCATOR**

- It manages 2(4)K byte page write and read request from Spw link
- Logical to physical address translation is implemented to manage overwrite requests of the same physical page
- Logical address is written into spare area of NAND physical page because random page programming within a block is prohibited (pages have to be written sequentially !)
- ECC is written into spare area of NAND page to protect both data and metadata
- A Hybrid-mapping Translation Layer based on LOG buffer is used to defer the time-consuming block erase operations.
- Block Mapping Table (BMT) for data blocks and Sector Mapping Table (SMT) for log blocks are stored in SRAM memory.
- Log blocks are used to handle page overwrites.

Nand Flash Address Translation (4)

❑ **BAD BLOCKS MANAGEMENT**

- NAND Flash are shipped with some bad blocks marked as invalid by vendor
- A bad block table all invalid blocks addresses
- Bad block table is updated with blocks that worn out during device life time

❑ **WEAR LEVELER**

- Evenly distribute the number of erasures of each block to improve device endurance
- Static wear leveling method is implemented
- SRAM tables are used to keep number of erasures of each block and to select victim block

Nand Flash Address Translation (5)

❑ **GARBAGE COLLECTOR**

- NAND FLASH device accumulates obsolete pages and the number of free available pages decrease: GC is used to recycle the blocks occupied by the obsolete pages and reclaims free space
- On-demand: GC reclaims free blocks when the number of free blocks is under a certain threshold
- Background: GC cleans obsolete blocks by performing block erase operations and puts them into free blocks pool
- SRAM tables are used to read/mark the status of each block(free/data/log/dirty/bad/mem)

Nand Flash Address Translation (6)

❑ **POWER OFF**

- A block of NAND FLASH is used to store the copy of the SRAM tables into a non-volatile memory in order to save address mapping tables and other vital info
- Standard power off: SRAM tables are saved to NAND FLASH when a power off request occurs
- Recovery Power off: copy of the SRAM table is done periodically to work as back up copy in case of sudden power off

❑ **POWER ON**

- First power on: SRAM tables are initialized and later saved into a NAND FLASH block
- Power on: SRAM tables are loaded retrieving the last copy saved in NAND FLASH

Error Correction Code (1)

All data and metadata in NAND Flash and in off-chip \ on-chip RAMs are protected with a specific ECC

The IMMIPC is equipped with 4 distinct codec engines

- ❑ BCH code protecting 2 (4)KB Nand FLASH data page;
- ❑ A SEC-DED code protecting the Logical Sector Address;
- ❑ A repetition code protecting the binary information of the RAM-table copy in a NAND block;
- ❑ SEC-DED codes to protect data stored in external SRAM and internal Block-RAMs.

Error Correction Code (2)

BCH (Bose Chaudhuri Hocquenghem) codec

- ❑ length of the code : 2048+29 bytes
- ❑ length of info. word : 2048 bytes
- ❑ number of parity bits : 225 bits (stored in the spare sector)
- ❑ Random error-correcting capability : 15 bits
- ❑ Coding rate $2048/(2048+29)$: 0.986
- ❑ Fast decoding process\low latency: byte-oriented solution, 15 Galois-Multipliers working in parallel → code size + 71 cycles latency between the first byte provided by the Flash memory and the first decoded byte.
- ❑ BCH codec area occupation on Actel ProAsic3 A3PE3000 @ 25MHz : 30% logic resources \ 6% Block-RAMs

Error Correction Code (3)

LSA codec

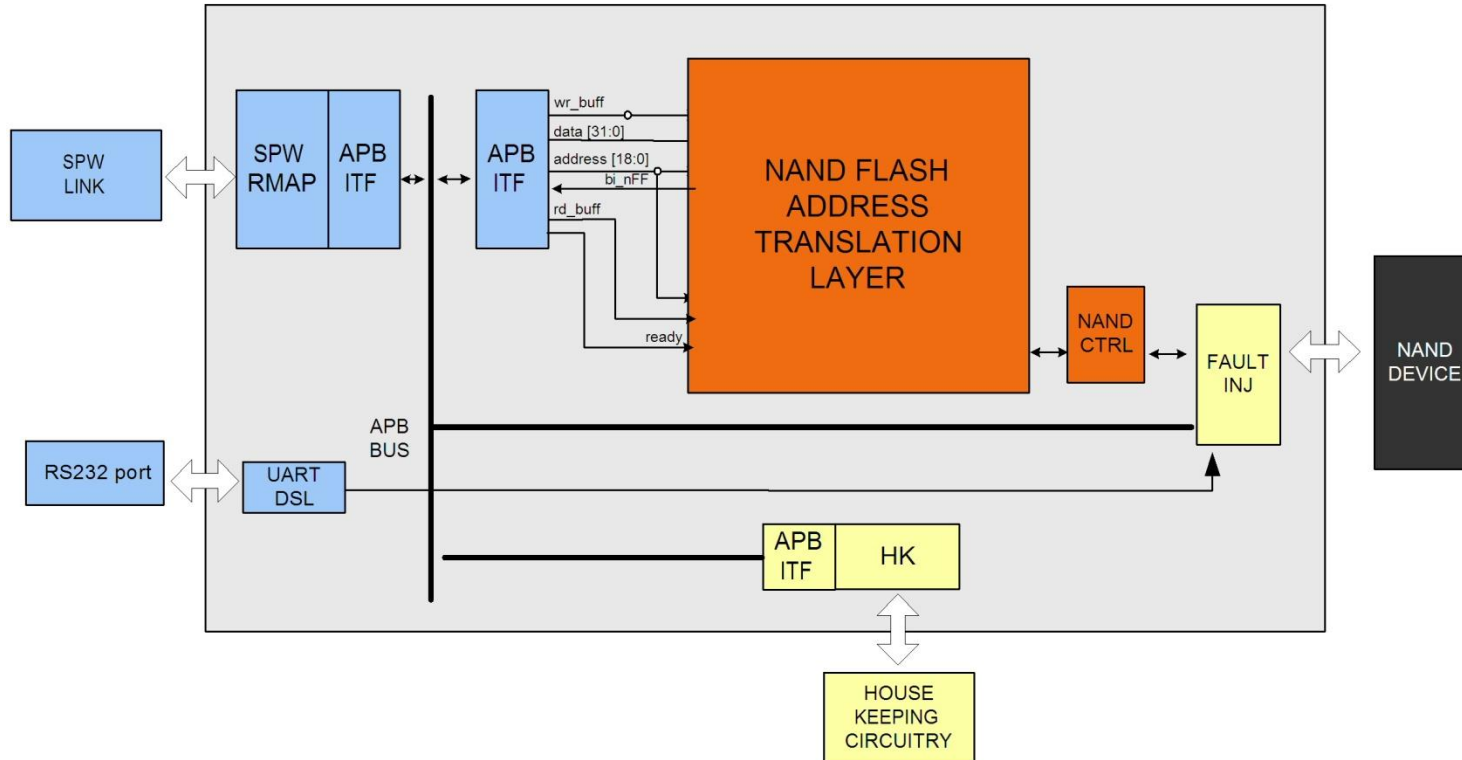
- ❑ SEC-DED code protecting the LSA (Logical Sector Address)
- ❑ length of codeword : 21 bits (LSA) + 7 bits (parity bits)
- ❑ Stored into spare sector of the NAND Flash

Majority decoder

- ❑ Repetition decoding is done using majority logic detection
- ❑ The code chosen is a repetition of '1' or '0' 7 times, in a single byte into spare area. All zero word identifies a RAM Table - copy block
- ❑ Random error-correcting capability: 3.

Communication Stack

- ❑ SpW-RMAP as host interface
- ❑ DSU like protocol on serial RS232 for test (Fault Injection)
- ❑ APB bus for Control and Test.



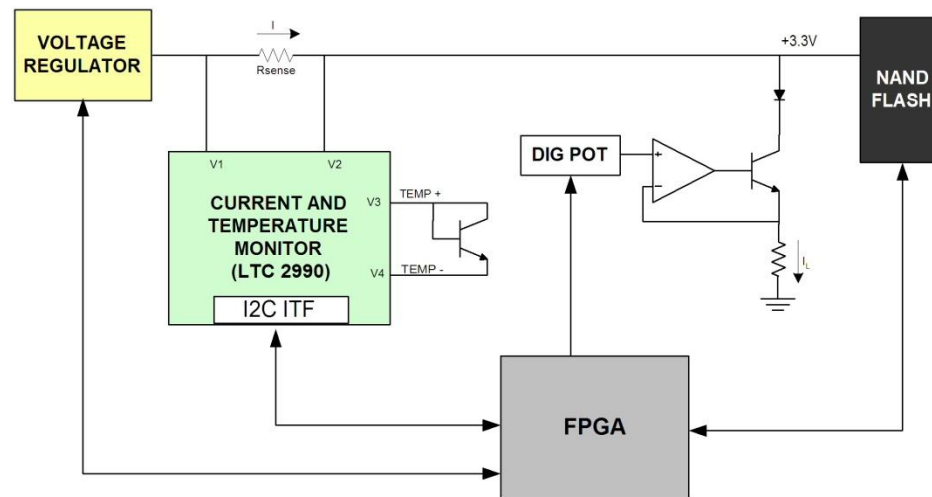
Test Utilities

❑ Fault Injector on the Nand Flash interface

- Programmable for errors number, error rate or pseudo-random function
- Controllable via RS232 or APB

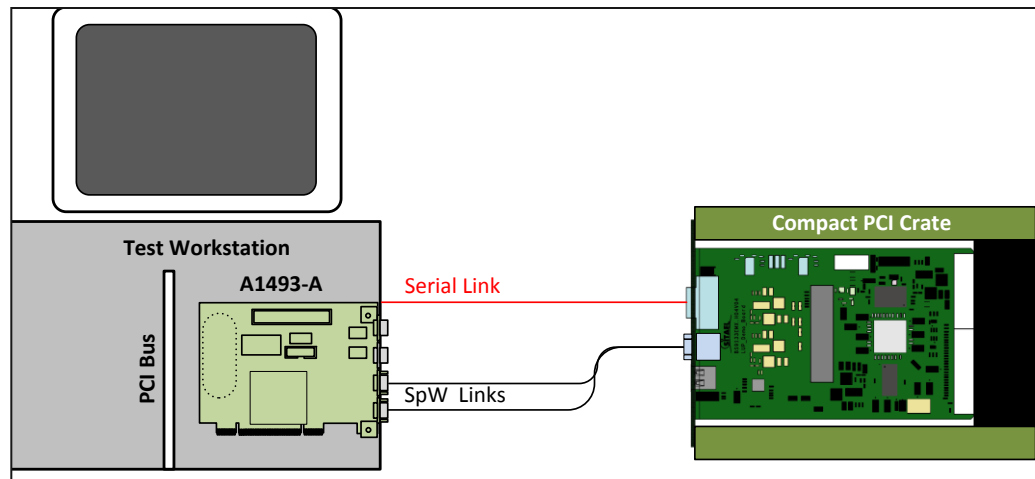
❑ HK circuit

- Nand FLASH Current and Board Temperature monitoring with the LTC 2990 IC (I2C interface, 14 bit ADC)
- Programmable threshold for auto power-off request
- Latch-up emulator based on a voltage controlled current sink

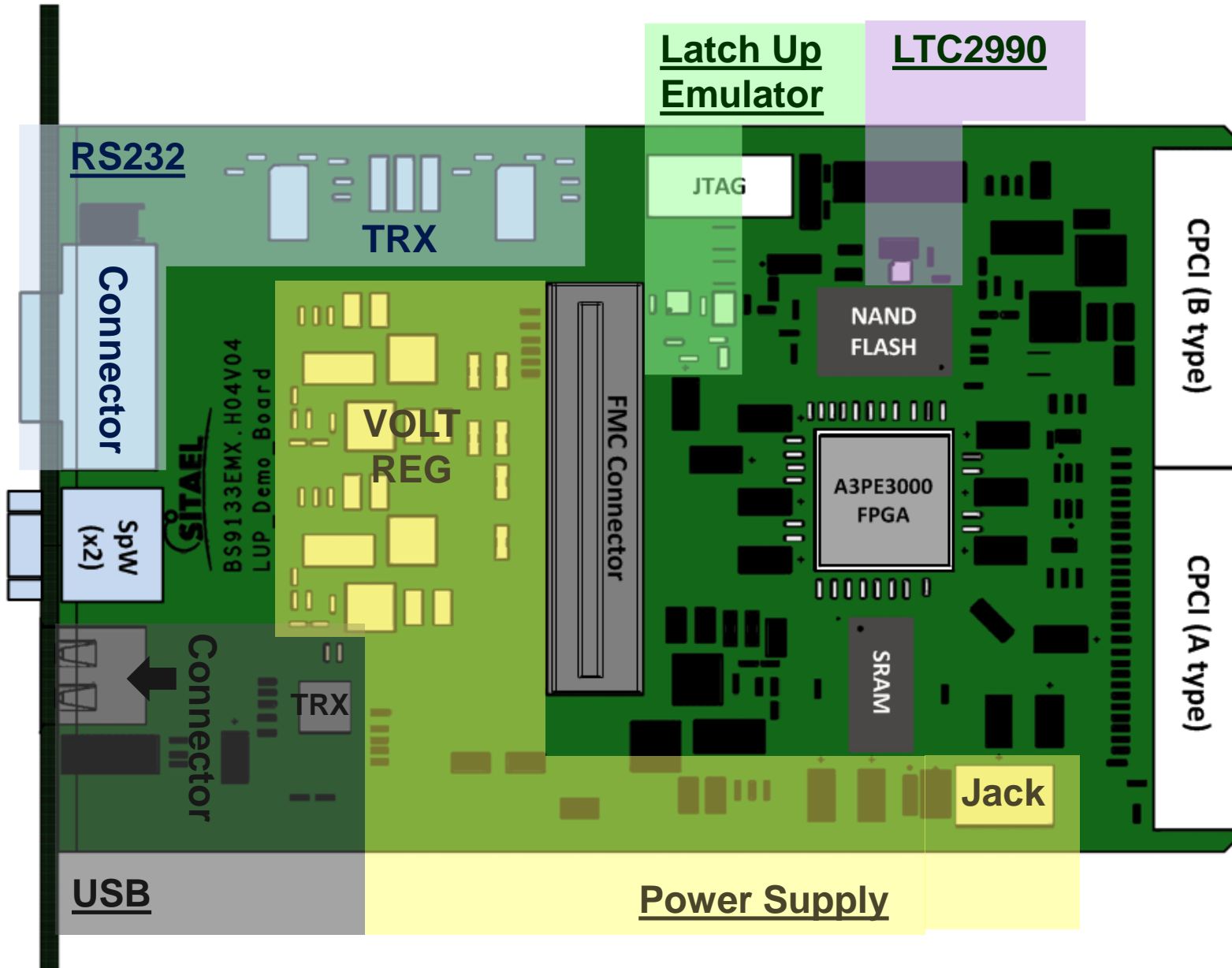


Demo Board

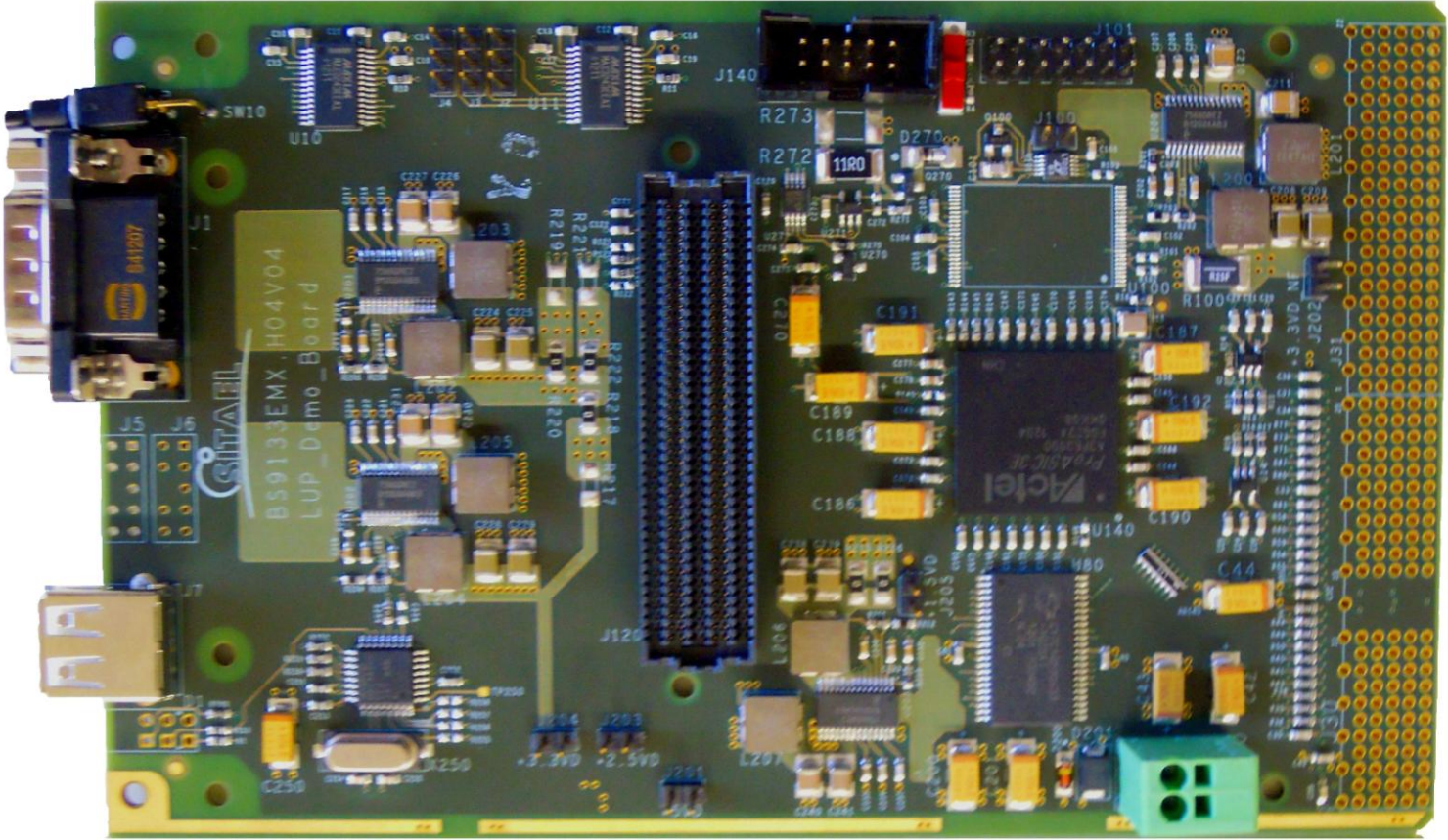
- ❑ CompactPCI 3U-8HP (RASTA compliant)
- ❑ Actel ProASIC3E A3PE3000
- ❑ Nand FLASH Micron MT29F64G08AJABA (UUT) 64Gbit with dedicated power Supply
- ❑ SRAM Buffer 1Mx8
- ❑ HK circuit based on I2C current and temperature monitor LTC2990 + Latch-Up emulator
- ❑ SpaceWire 2x ports + Serial RS232



Demo Board Layout



Demo Board Photo



Conclusions and Next Steps

❑ **Project Status**

- IMM architectural and detailed design complete
- Manufacturing completed

❑ **Activities in Progress**

- Test on Demo Board
- IP Core Consolidation
- RASTA Environment Integration

❑ **Next Steps**

- Demo Application test case
- NFATL algorithms evaluation/refinement



***Thank you for your
attention!***

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Spare 0

□ NAND FLASH timings:

- TSOP package asynchronous interface 50Mhz with DutyCycle1/2 == access time = 40 ns
- BGA package synchronous interface 100Mhz DDR == access time 5 ns
- 1 page = 2 Kbyte
- 1 page program = internal reg write + programming time = 85000 ns (@50Mhz)+ 200us =~ 285 us
- 1 page read = latency + internal reg read = 25 us + 85000 ns (@50Mhz) =~ 110 us
- 1 block = 128 page erase = 700 us

□ NFATL timings:

- 1 page = 2 Kbyte; 4096 blocks; 4 log block
- NFATL write: sequential page write min=326 us ; max 4 ms =~ (25+5) us * 128
- NFATL write: overwrite =~ 2 x sequential write
- NFATL write: overwrite + new log block =~ 23 ms
- NFATL read: min 230 us; max 5 ms =~ (25+5) us * 128 + log block scan

Spare 1

□ **NAFTL FSM complexity:**

- System scheduler == 10 states
- DMA engine == 32 state

- Allocator == 467 states
- Bad blocks Manager == 30 states
- Power off == 66 states
- Power on == 42 states

Spare (2)

BCH Vs DSCC (Difference Set Cyclic Code)

- ❑ Goal: strong random error protection with smallest complexity;
- ❑ 2 principals block-codes have been considered: BCH codes and DSCC codes (no RS codes, since burst errors aren't the main occurrence in NAND Flash soft errors events);
- ❑ BCH code has better performance for 2\4KB of block-length: fewer redundancy symbols in order to correct the same amount of random bit-errors;
- ❑ BCH decoding architecture is slightly smaller and faster (considering multiple Galois multipliers);
- ❑ BCH code guarantee the best fitting-factor for the granularity of the Flash memory: 2\4KB in data sector and ECC parity string into spare amounts.

Spare 2

□ **NAFTL FSM complexity:**

- System scheduler == 10 states
- DMA engine == 32 state

- Allocator == 467 states
- Bad blocks Manager == 30 states
- Power off == 66 states
- Power on == 42 states